

### Circuits from the Lab™ Reference Circuits

Circuits from the Lab™ reference circuits are engineered and tested for quick and easy system integration to help solve today's analog, mixed-signal, and RF design challenges. For more information and/or support, visit [www.analog.com/CN0183](http://www.analog.com/CN0183).

#### Devices Connected/Referenced

<a href="#">AD5668</a>	16-Bit Voltage Output <i>dense</i> DAC with 5 ppm/°C On-Chip Reference and SPI Interface
<a href="#">AD8638</a>	16 V Auto-Zero, Rail-to-Rail Output Op Amp
<a href="#">ADP2300</a>	1.2 A, 20 V, 700 kHz, Nonsynchronous Step-Down Switching Regulator
<a href="#">REF192</a>	Precision Micropower, 2.5 V Low Dropout Voltage Reference

## Precision 16-Bit, Bipolar Output Voltage Source with +12 V to ±5 V Supply

### EVALUATION AND DESIGN SUPPORT

#### Circuit Evaluation Boards

[CN-0183 Circuit Evaluation Board \(EVAL-CN0183-SDZ\)](#)  
[System Demonstration Platform \(EVAL-SDP-CB1Z\)](#)

#### Design and Integration Files

[Schematics, Layout Files, Bill of Materials](#)

### CIRCUIT FUNCTION AND BENEFITS

The circuit shown in Figure 1 provides a precision 16-bit, low drift bipolar voltage output of  $\pm 2.5$  V and operates on a single +10 V to +15 V supply. The unipolar voltage outputs of the [AD5668](#) octal *dense*DAC are amplified and level shifted by the [AD8638](#) auto-zero op amps. The maximum drift contribution

of the [AD8638](#) is only 0.06 ppm/°C. The external [REF192](#) reference ensures a maximum drift of 5 ppm/°C (E grade) and provides a low impedance pseudo ground for the [AD8638](#) level gain and shifting circuit.

The circuit offers an efficient solution to a problem often encountered in systems with a single +12 V supply rail. Proper printed circuit board (PCB) layout and grounding techniques ensure that the [ADP2300](#) switching regulator does not degrade the overall performance of the circuit.

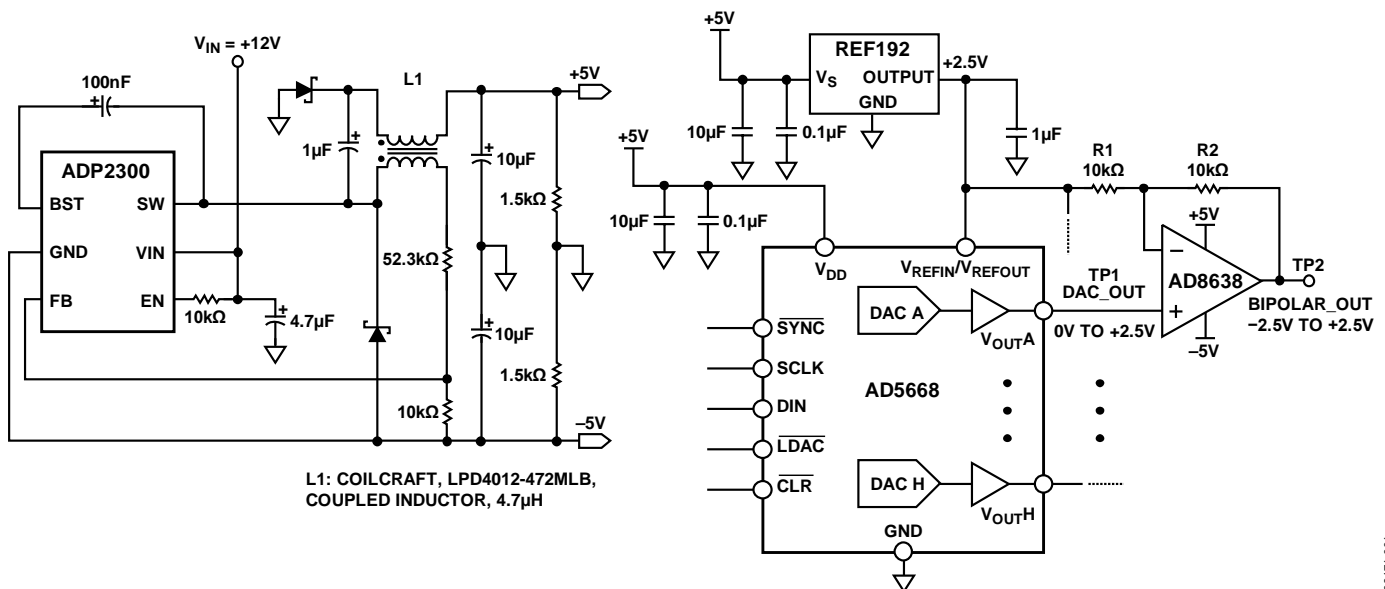


Figure 1. Bipolar Output DAC Circuit with  $\pm 5$  V Power Supplies

#### Rev. 0

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## CIRCUIT DESCRIPTION

The **AD5668** is a 16-bit, octal, voltage output *denseDAC* controlled by an SPI interface. It contains an on-chip reference with a 10 ppm/°C maximum drift specification. The on-chip reference is off at power-up, allowing the use of an external reference. The internal reference is enabled via a software write. In the circuit shown in Figure 1, an external **REF192** is used because a low output impedance is required to drive the 2.5 V pseudo ground reference for the **AD8638** op amps.

The output voltage of the **AD5668** is 0 V to 2.5 V at TP1, and this signal drives the noninverting input of the **AD8638** op amp. The signal gain of the op amp is  $1 + R2/R1$ , which is 2 for  $R1 = R2$ . A negative 2.5 V offset is injected into the op amp output by driving  $R1$  with the 2.5 V reference. The result is a bipolar output voltage at TP2 that swings from -2.5 V to +2.5 V.

The circuit operates on a single supply voltage of nominally 12 V, which can vary between 10 V and 15 V. The regulated -5 V supply rail is developed from an **ADP2300** switching regulator connected in the inverting buck-boost configuration. The circuit can be designed using the **ADIsimPower** program available at [www.analog.com/ADIsimPower](http://www.analog.com/ADIsimPower). The L1 coupled inductor is used to develop an unregulated 5 V supply for the circuit using a Zeta configuration. This circuit yields high efficiency for small output currents.

The integral nonlinearity (INL) and differential nonlinearity (DNL) measured at TP2 (bipolar output) are shown in Figure 2 and Figure 3, respectively.

The INL and DNL measured at TP1 (unipolar DAC output) are shown in Figure 4 and Figure 5, respectively.

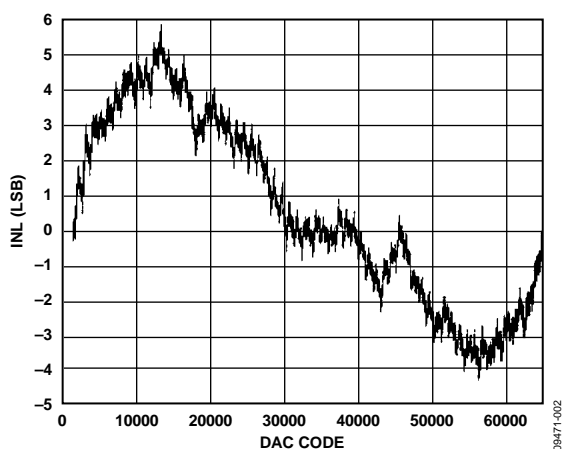


Figure 2. INL Performance of Bipolar Output (TP2)

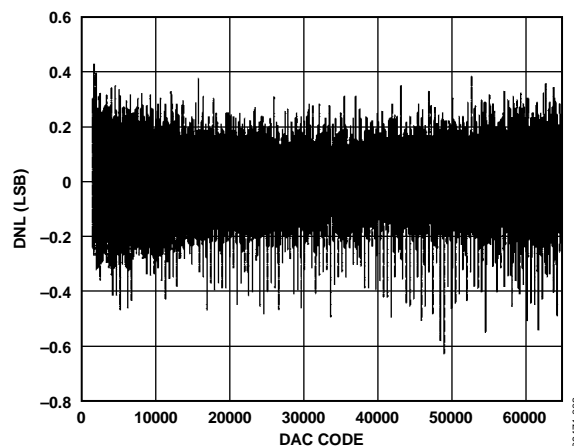


Figure 3. DNL Performance of Bipolar Output (TP2)

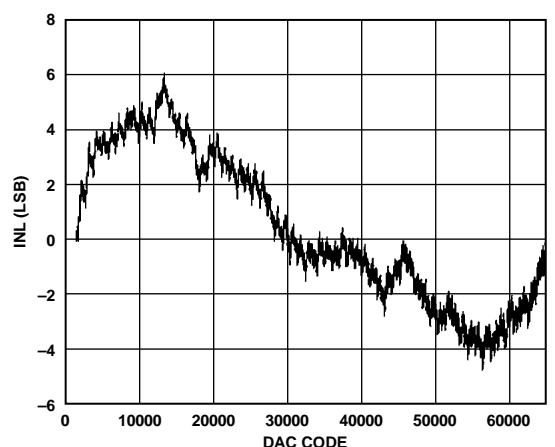


Figure 4. INL Performance of Unipolar DAC Output (TP1)

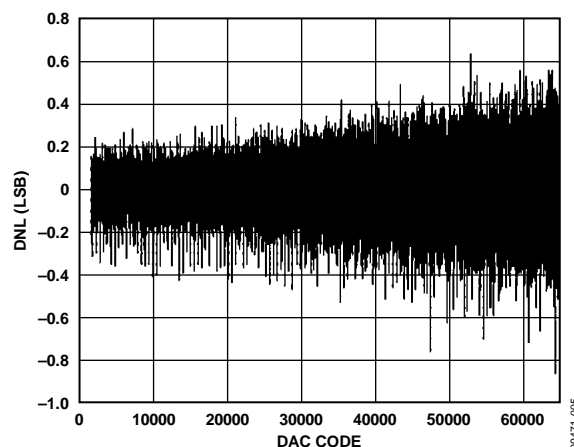


Figure 5. DNL Performance of Unipolar DAC Output (TP1)

## COMMON VARIATIONS

The [AD5628](#) and [AD5648](#) are 12-bit and 14-bit versions of the [AD5668](#). All have an on-chip reference with an internal gain of 2. The [AD5628-1/AD5648-1/AD5668-1](#) have a 1.25 V, 5 ppm/°C reference, giving a full-scale output range of 2.5 V; and the [AD5628-2/AD5648-2/AD5668-2](#) and [AD5668-3](#) have a 2.5 V, 5 ppm/°C reference, giving a full-scale output range of 5 V. The on-board reference is off at power-up, allowing the use of an external reference. The internal reference is enabled via a software write. The part incorporates a power-on-reset circuit that ensures that the DAC output powers up to 0 V ([AD5628-1/AD5648-1/AD5668-1](#), [AD5628-2/AD5648-2/AD5668-2](#)) or midscale ([AD5668-3](#)) and remains powered up at this level until a valid write takes place.

The [AD8639](#) is a dual version of the [AD8638](#) and can be used, if desired. The circuit in Figure 1 uses the single [AD8638](#) to minimize crosstalk between the eight channels.

Other 2.5 V references can be used, such as the [ADR4525](#), which has an accuracy of  $\pm 0.02\%$  and a temperature coefficient of 2 ppm/°C maximum (B grade).

## CIRCUIT EVALUATION AND TEST

### Equipment Needed (Equivalents Can Be Substituted)

The following equipment is needed:

- The System Demonstration Platform ([EVAL-SDP-CB1Z](#))
- The [CN-0183](#) circuit evaluation board ([EVAL-CN0183-SDZ](#))
- The [CN-0183](#) evaluation software
- The Tektronix TDS2024, 4-channel oscilloscope
- The HP E3630A 0 V to 6 V/2.55 A;  $\pm 20$  V/0.5 A triple output dc power supply
- A PC (Windows 32-bit or 64-bit)

## Getting Started

Load the evaluation software by placing the [CN-0183](#) evaluation software CD in the CD drive of the PC. Using **My Computer**, locate the drive that contains the evaluation software CD and open the **Readme** file. Follow the instructions contained in the **Readme** file for installing and using the evaluation software. The evaluation software main window is shown in Figure 6.

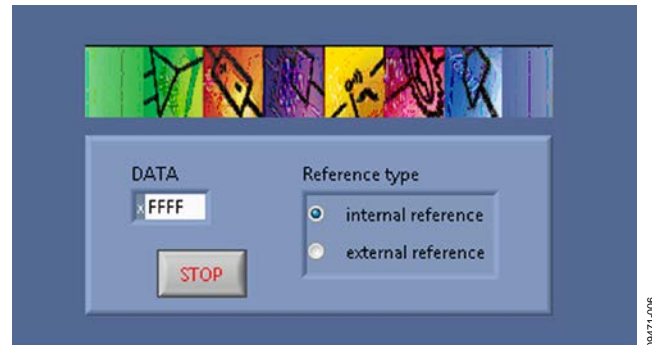


Figure 6. Evaluation Software Main Window

## Functional Diagram of Test Setup

A functional diagram of the test setup is shown in Figure 7. This setup allows the DAC output (TP1) and the bipolar output (TP2) to be observed with an oscilloscope.

Linearity measurements require a precision, digital voltmeter (DVM) that can be read by the PC via a USB port.

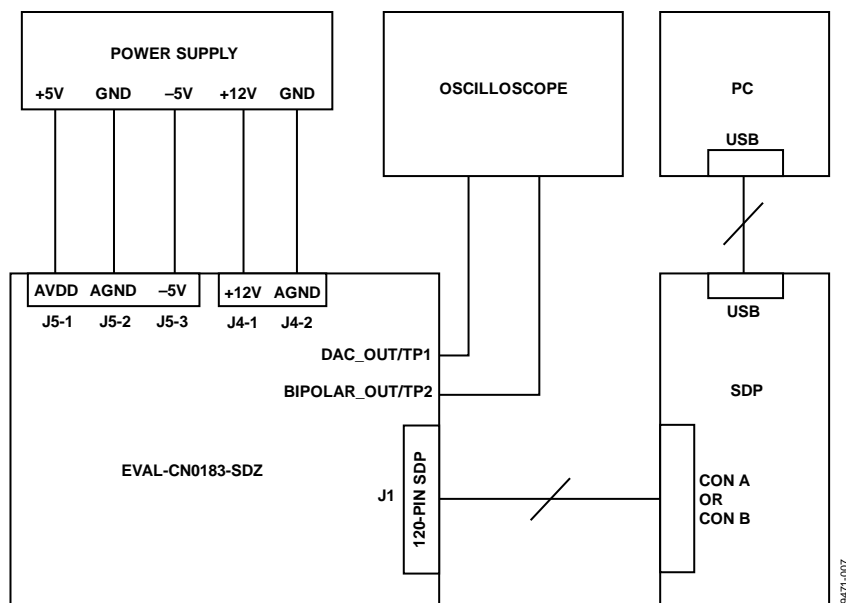


Figure 7. Functional Diagram of Test Setup

**Setup**

Connect the 120-pin connector on the [EVAL-CN0183-SDZ](#) to the **CON A** connector or the **CON B** connector on the [EVAL-SDP-CB1Z](#). Use nylon hardware to firmly secure the two boards, using the holes provided at the ends of the 120-pin connectors. After successfully setting the dc output supply to +5 V, –5 V, and +12 V, turn the power supply off.

With power to the supply off, connect the –5 V power supply to the –5V pin on J5-3, connect the +5 V power supply to the AVDD pin on J5-1, connect GND to the AGND pins on J5-2 and J4-2, and connect the +12 V power supply to the +12V pin on J4-1. Alternatively, place Link 2 and Link 3 in Position B to power the circuitry using the [ADP2300](#) to supply +5 V and –5 V. Note that AVDD and the –5 V are not needed in this case.

Turn on the power supply and then connect the USB cable from the SDP board to the USB port on the PC. Do not connect the USB cable to the mini-USB connector on the SDP before turning on the dc power supply for the [EVAL-CN0183-SDZ](#).

After setting up the test equipment, connect the probes of the oscilloscope to the TP1 and TP2 test points. The TP3, TP4, and TP5 test points are connected to the reference, the regulated +5 V, and the regulated –5 V, respectively. Check these test points for the correct voltages (use TP6 for the ground).

The software provided on the CD allows users to set the value of  $V_{OUTA}$  by loading a code into the DAC and by choosing the source of the reference. If users keep the default setting, they will have to supply the +5 V and –5 V voltages, and the +12 V is not required. The default setting uses the external [REF192](#) reference, giving you a full-scale DAC output range of 2.5 V (TP1), and –2.5 V to +2.5 V on the bipolar output (TP2). Loading 0x0000 sets the DAC output to 0 V and the bipolar output to –2.5 V. Loading 0x8000 sets the DAC output to 1.25 V and the bipolar output to 0 V. Loading 0xFFFF sets the DAC output to 2.5 V and the bipolar output to 2.5 V.

**Table 1. Jumper Settings for [EVAL-CN0183-SDZ](#) (Default Settings in Bold)**

Jumper	Description	Setting	Function
LK1	Short <a href="#">AD5668</a> reference pin to <a href="#">REF192</a> output	<b>Inserted</b>	<b>It shorts <a href="#">AD5668</a> reference pin to <a href="#">REF192</a> output allowing the use of an external DAC reference.</b>
		Opened	Only the internal reference of the <a href="#">AD5668</a> can be used.
LK2	AVDD supply source	<b>Position A</b>	<b>The circuit is powered by an external 5 V supply applied to the AVDD pin on J5-1.</b>
		Position B	The digital power is supplied by the 5 V voltage supplied by the <a href="#">ADP2300</a> regulator.
LK5	–5 V voltage source	<b>Position A</b>	<b>The analog circuit is supplied by an external power supply apply to the –5V pin on J5-3.</b>
		Position B	The digital power is supplied by the –5 V voltage obtained by inverting the output of the <a href="#">ADP2300</a> regulator.

**LEARN MORE**

CN-0183 Design Support Package:

<http://www.analog.com/CN0183-DesignSupport>

Ardizzoni, John. *A Practical Guide to High-Speed Printed-Circuit-Board Layout*, Analog Dialogue 39-09, September 2005.

MT-031 Tutorial, *Grounding Data Converters and Solving the Mystery of "AGND" and "DGND"*, Analog Devices.

MT-101 Tutorial, *Decoupling Techniques*, Analog Devices.

ADIsimPower Design Tool

**Data Sheets and Evaluation Boards**

CN-0183 Circuit Evaluation Board (EVAL-CN0183-SDZ)

System Demonstration Platform (EVAL-SDP-CB1Z)

AD5668 Data Sheet and Evaluation Board

AD8638 Data Sheet and Evaluation Board

ADP2300 Data Sheet and Evaluation Board

REF192 Data Sheet and Evaluation Board

**REVISION HISTORY**

6/12—Rev. 0: Initial Version

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